

Docket No.: 87414.1580

PATENT OFFICIAL



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

RECEIVED
SEP 04 2003
TC 1700

In re Application of

Confirmation No.: 5350

Markus BEER, et al.

Serial No. 10 087,953

Group Art Unit: 1724

Filed: March 5, 2002

Examiner: Frank M. LAWRENCE, Jr.

For: MULTILAYER COMPOSITE FILTER MEDIUM FOR SERIAL FILTRATION

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

No further elaboration is believed necessary. Copies of the documents are submitted herewith in accordance with 37 C.F.R. §1.98(a).

Docket No.: 87414.1580



PATENT OFFICIAL

RECEIVED
SEP 04 2003
TC 1700

AUTHORIZATION

This Information Disclosure Statement is being filed after receipt of the first Office Action.

A fee in the amount of \$180.00 is required. The Commissioner is hereby authorized to charge \$180.00 to Deposit Account No. 50-2036.

Respectfully submitted,

BAKER & HOSTETLER LLP

A handwritten signature in black ink, appearing to read "Michael D. Graham".

Michael D. Graham
Registration No. 51,750

Date: September 2, 2003
Baker & Hostetler LLP
Washington Square, Suite 1100
1050 Connecticut Avenue, N.W.
Washington, D.C. 20036
Telephone: (202) 861 1500
Facsimile: (202) 861 1783



LIST OF ART CITED BY APPLICANT

(PTO-1449)

ATTY. DOCKET NO.

87414.1580

SERIAL NO.

10/087.953

APPLICANT

Markus BEER et al.

FILING DATE

March 5, 2002

GROUP

1724

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
A	6,193,773	02/27/01	schlor et al.	55	382	
B	5,770,077	06/23/98	Goldman	210	490	
C	5,701,893	12/30/97	kern et al.	128	206.24	
D						
E						
F						
G						
H						
I						
J						
K						
L						
M						
N						
O						
P						
Q						
R						
S						
T						

RECEIVED
SEP 04 2003
TC 1700

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation
U						
V						
W						
X						
Y						
Z						
AA						
BB						
CC						
DD						
EE						
FF						
GG						

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

HH
II
JJ
KK
LL
MM
NN

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.